# E·XFL



#### Welcome to E-XFL.COM

#### Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

#### Applications of **Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

#### Details

Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	1.0GHz
Co-Processors/DSP	Signal Processing; SPE
RAM Controllers	DDR, DDR2, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCPBGA (29x29)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8547vtaqgd

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

# 2 Electrical Characteristics

This section provides the AC and DC electrical specifications and thermal characteristics for the device. This device is currently targeted to these specifications. Some of these specifications are independent of the I/O cell, but are included for a more complete reference. These are not purely I/O buffer design specifications.

# 2.1 **Overall DC Electrical Characteristics**

This section covers the ratings, conditions, and other characteristics.

# 2.1.1 Absolute Maximum Ratings

The following table provides the absolute maximum ratings.

Table 1. Absolute	Maximum	Ratings	1
-------------------	---------	---------	---

Characteristic		Symbol	Max Value	Unit	Notes
Core supply vo	bltage	V <sub>DD</sub>	-0.3 to 1.21	V	—
PLL supply vol	tage	AV <sub>DD</sub>	-0.3 to 1.21	V	—
Core power su	pply for SerDes transceivers	SV <sub>DD</sub>	-0.3 to 1.21	V	—
Pad power sup	oply for SerDes transceivers	XV <sub>DD</sub>	-0.3 to 1.21	V	—
DDR and DDR	2 DRAM I/O voltage	GV <sub>DD</sub>	-0.3 to 2.75 -0.3 to 1.98	V	2
Three-speed E	thernet I/O voltage	LV <sub>DD</sub> (for eTSEC1 and eTSEC2)	-0.3 to 3.63 -0.3 to 2.75	V	
		TV <sub>DD</sub> (for eTSEC3 and eTSEC4)	-0.3 to 3.63 -0.3 to 2.75		3
PCI/PCI-X, DUART, system control and power management, I <sup>2</sup> C, Ethernet MII management, and JTAG I/O voltage		OV <sub>DD</sub>	-0.3 to 3.63	V	_
Local bus I/O voltage		BV <sub>DD</sub>	-0.3 to 3.63 -0.3 to 2.75	V	—
Input voltage	DDR/DDR2 DRAM signals	MV <sub>IN</sub>	–0.3 to (GV <sub>DD</sub> + 0.3)	V	4
	DDR/DDR2 DRAM reference	MV <sub>REF</sub>	-0.3 to (GV <sub>DD</sub> /2 + 0.3)	V	—
	Three-speed Ethernet I/O signals	LV <sub>IN</sub> TV <sub>IN</sub>	-0.3 to (LV <sub>DD</sub> + 0.3) -0.3 to (TV <sub>DD</sub> + 0.3)	V	4
	Local bus signals	BV <sub>IN</sub>	-0.3 to (BV <sub>DD</sub> + 0.3)	_	—
	DUART, SYSCLK, system control and power management, I <sup>2</sup> C, Ethernet MII management, and JTAG signals	OV <sub>IN</sub>	-0.3 to (OV <sub>DD</sub> + 0.3)	V	4
	PCI/PCI-X	OV <sub>IN</sub>	-0.3 to (OV <sub>DD</sub> + 0.3)	V	4

Characteristic		Recommended Value	Unit	Notes
Junction temperature range	Tj	0 to 105	°C	_

#### Table 2. Recommended Operating Conditions (continued)

#### Notes:

1. This voltage is the input to the filter discussed in Section 22.2, "PLL Power Supply Filtering," and not necessarily the voltage at the AV<sub>DD</sub> pin, which may be reduced from V<sub>DD</sub> by the filter.

- Caution: MV<sub>IN</sub> must not exceed GV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
- 3. Caution: OV<sub>IN</sub> must not exceed OV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
- 4. Caution: L/TV<sub>IN</sub> must not exceed L/TV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.

The following figure shows the undershoot and overshoot voltages at the interfaces of this device.



The core voltage must always be provided at nominal 1.1 V. Voltage to the processor interface I/Os are provided through separate sets of supply pins and must be provided at the voltages shown in Table 2. The input voltage threshold scales with respect to the associated I/O supply voltage.  $OV_{DD}$  and  $LV_{DD}$  based receivers are simple CMOS I/O circuits and satisfy appropriate LVCMOS type specifications. The DDR SDRAM interface uses a single-ended differential receiver referenced the externally supplied  $MV_{REF}$  signal (nominally set to  $GV_{DD}/2$ ) as is appropriate for the SSTL2 electrical signaling standard.

## 2.1.3 Output Driver Characteristics

The following table provides information on the characteristics of the output driver strengths. The values are preliminary estimates.

Driver Type	Programmable Output Impedance (Ω)	Supply Voltage	Notes
Local bus interface utilities signals	25 25	BV <sub>DD</sub> = 3.3 V BV <sub>DD</sub> = 2.5 V	1
	45(default) 45(default)	BV <sub>DD</sub> = 3.3 V BV <sub>DD</sub> = 2.5 V	
PCI signals	25	OV <sub>DD</sub> = 3.3 V	2
	45(default)		
DDR signal	18 36 (half strength mode)	GV <sub>DD</sub> = 2.5 V	3
DDR2 signal	18 36 (half strength mode)	GV <sub>DD</sub> = 1.8 V	3
TSEC/10/100 signals	45	L/TV <sub>DD</sub> = 2.5/3.3 V	
DUART, system control, JTAG	45	OV <sub>DD</sub> = 3.3 V	—
12C	150	OV <sub>DD</sub> = 3.3 V	_

Table 3. Output Drive Capability

Notes:

1. The drive strength of the local bus interface is determined by the configuration of the appropriate bits in PORIMPSCR.

2. The drive strength of the PCI interface is determined by the setting of the PCI\_GNT1 signal at reset.

3. The drive strength of the DDR interface in half-strength mode is at  $T_i = 105^{\circ}C$  and at  $GV_{DD}$  (min).

# 2.2 Power Sequencing

The device requires its power rails to be applied in a specific sequence in order to ensure proper device operation. These requirements are as follows for power-up:

- 1. V<sub>DD</sub>, AV<sub>DD</sub>, BV<sub>DD</sub>, LV<sub>DD</sub>, OV<sub>DD</sub>, SV<sub>DD</sub>, TV<sub>DD</sub>, XV<sub>DD</sub>
- 2.  $GV_{DD}$

All supplies must be at their stable values within 50 ms.

### NOTE

Items on the same line have no ordering requirement with respect to one another. Items on separate lines must be ordered sequentially such that voltage rails on a previous step must reach 90% of their value before the voltage rails on the current step reach 10% of theirs.

### NOTE

In order to guarantee MCKE low during power-up, the above sequencing for  $GV_{DD}$  is required. If there is no concern about any of the DDR signals being in an indeterminate state during power-up, then the sequencing for  $GV_{DD}$  is not required.

Table 13 provides the recommended operating conditions for the DDR SDRAM controller when  $GV_{DD}(typ) = 2.5 \text{ V}.$ 

Parameter/Condition	Symbol	Min	Max	Unit	Notes
I/O supply voltage	GV <sub>DD</sub>	2.375	2.625	V	1
I/O reference voltage	MV <sub>REF</sub>	$0.49 \times GV_{DD}$	$0.51 \times GV_{DD}$	V	2
I/O termination voltage	V <sub>TT</sub>	MV <sub>REF</sub> – 0.04	MV <sub>REF</sub> + 0.04	V	3
Input high voltage	V <sub>IH</sub>	MV <sub>REF</sub> + 0.15	GV <sub>DD</sub> + 0.3	V	—
Input low voltage	V <sub>IL</sub>	-0.3	MV <sub>REF</sub> – 0.15	V	—
Output leakage current	I <sub>OZ</sub>	-50	50	μA	4
Output high current (V <sub>OUT</sub> = 1.95 V)	I <sub>OH</sub>	-16.2	—	mA	—
Output low current ( $V_{OUT} = 0.35 V$ )	I <sub>OL</sub>	16.2	—	mA	—

Table 13	DDR SDRAM	DC Electrical	Characteristics	for GV	(tvn) = 2	25 V
Table 15.	DDIX SDIXAM		Gilaracteristics		(()) – 4	1.J V

#### Notes:

1.  ${\rm GV}_{\rm DD}$  is expected to be within 50 mV of the DRAM  ${\rm V}_{\rm DD}$  at all times.

2. MV<sub>REF</sub> is expected to be equal to 0.5 × GV<sub>DD</sub>, and to track GV<sub>DD</sub> DC variations as measured at the receiver. Peak-to-peak noise on MV<sub>REF</sub> may not exceed ±2% of the DC value.

3. V<sub>TT</sub> is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MV<sub>REF</sub>. This rail must track variations in the DC level of MV<sub>REF</sub>.

4. Output leakage is measured with all outputs disabled, 0 V  $\leq$  V<sub>OUT</sub>  $\leq$  GV<sub>DD</sub>.

Table 14 provides the DDR I/O capacitance when  $GV_{DD}(typ) = 2.5$  V.

#### Table 14. DDR SDRAM Capacitance for GV<sub>DD</sub>(typ) = 2.5 V

Parameter/Condition	Symbol	Min	Мах	Unit	Notes
Input/output capacitance: DQ, DQS	C <sub>IO</sub>	6	8	pF	1
Delta input/output capacitance: DQ, DQS	C <sub>DIO</sub>	—	0.5	pF	1

#### Note:

1. This parameter is sampled.  $GV_{DD} = 2.5 \text{ V} \pm 0.125 \text{ V}$ , f = 1 MHz, T<sub>A</sub> = 25°C,  $V_{OUT} = GV_{DD}/2$ ,  $V_{OUT}$  (peak-to-peak) = 0.2 V.

This table provides the current draw characteristics for MV<sub>REF</sub>.

#### Table 15. Current Draw Characteristics for MV<sub>REF</sub>

Parameter/Condition	Symbol	Min	Мах	Unit	Notes
Current draw for MV <sub>REF</sub>	I <sub>MVREF</sub>		500	μA	1

#### Note:

1. The voltage regulator for  $MV_{REF}$  must be able to supply up to 500  $\mu$ A current.

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Local bus cycle time	t <sub>LBK</sub>	7.5	12	ns	2
Local bus duty cycle	t <sub>LBKH/</sub> t <sub>LBK</sub>	43	57	%	—
LCLK[n] skew to LCLK[m] or LSYNC_OUT	t <sub>LBKSKEW</sub>	_	150	ps	7, 8
Input setup to local bus clock (except LGTA/UPWAIT)	t <sub>LBIVKH1</sub>	1.9	—	ns	3, 4
LGTA/LUPWAIT input setup to local bus clock	t <sub>LBIVKH2</sub>	1.8	—	ns	3, 4
Input hold from local bus clock (except LGTA/LUPWAIT)	t <sub>LBIXKH1</sub>	1.1	—	ns	3, 4
LGTA/LUPWAIT input hold from local bus clock	t <sub>LBIXKH2</sub>	1.1	—	ns	3, 4
LALE output transition to LAD/LDP output transition (LATCH hold time)	t <sub>LBOTOT</sub>	1.5	—	ns	6
Local bus clock to output valid (except LAD/LDP and LALE)	t <sub>LBKHOV1</sub>	_	2.1	ns	—
Local bus clock to data valid for LAD/LDP	t <sub>LBKHOV2</sub>		2.3	ns	3
Local bus clock to address valid for LAD	t <sub>LBKHOV3</sub>		2.4	ns	3
Local bus clock to LALE assertion	t <sub>LBKHOV4</sub>		2.4	ns	3
Output hold from local bus clock (except LAD/LDP and LALE)	t <sub>LBKHOX1</sub>	0.8	—	ns	3
Output hold from local bus clock for LAD/LDP	t <sub>LBKHOX2</sub>	0.8	—	ns	3
Local bus clock to output high Impedance (except LAD/LDP and LALE)	t <sub>LBKHOZ1</sub>		2.6	ns	5
Local bus clock to output high impedance for LAD/LDP	t <sub>LBKHOZ2</sub>		2.6	ns	5

Table 41 describes the timing parameters of the local bus interface at  $BV_{DD} = 2.5$  V.

### Table 41. Local Bus Timing Parameters (BV<sub>DD</sub> = 2.5 V)—PLL Enabled

#### Notes:

The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t<sub>(first two letters of functional block)(reference)(state)(signal)(state) for outputs. For example, t<sub>LBIXKH1</sub> symbolizes local bus timing (LB) for the input (I) to go invalid (X) with respect to the time the t<sub>LBK</sub> clock reference (K) goes high (H), in this case for clock one (1). Also, t<sub>LBKH0X</sub> symbolizes local bus timing (LB) for the t<sub>LBK</sub> clock reference (K) to go high (H), with respect to the output (O) going invalid (X) or output hold time.
</sub></sub>

- 2. All timings are in reference to LSYNC\_IN for PLL enabled and internal local bus clock for PLL bypass mode.
- 3. All signals are measured from  $BV_{DD}/2$  of the rising edge of LSYNC\_IN for PLL enabled or internal local bus clock for PLL bypass mode to  $0.4 \times BV_{DD}$  of the signal in question for 3.3-V signaling levels.
- 4. Input timings are measured at the pin.

5. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.

- 6. t<sub>LBOTOT</sub> is a measurement of the minimum time between the negation of LALE and any change in LAD. t<sub>LBOTOT</sub> is programmed with the LBCR[AHD] parameter.
- Maximum possible clock skew between a clock LCLK[m] and a relative clock LCLK[n]. Skew measured between complementary signals at BV<sub>DD</sub>/2.
- 8. Guaranteed by design.

Figure 22 provides the AC test load for the local bus.



Figure 22. Local Bus AC Test Load

#### Local Bus



Figure 24. Local Bus Signals (PLL Bypass Mode)

### NOTE

In PLL bypass mode, LCLK[*n*] is the inverted version of the internal clock with the delay of  $t_{LBKHKT}$ . In this mode, signals are launched at the rising edge of the internal clock and are captured at falling edge of the internal clock with the exception of LGTA/LUPWAIT (which is captured on the rising edge of the internal clock).

#### Local Bus



Figure 28. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 8 or 16 (PLL Bypass Mode)

# 14 GP<sub>OUT</sub>/GP<sub>IN</sub>

This section describes the DC and AC electrical specifications for the GP<sub>OUT</sub>/GP<sub>IN</sub> bus of the device.

# 14.1 GP<sub>OUT</sub>/GP<sub>IN</sub> Electrical Characteristics

Table 47 and Table 48 provide the DC electrical characteristics for the GP<sub>OUT</sub> interface.

Parameter	Symbol	Min	Мах	Unit
Supply voltage 3.3 V	BV <sub>DD</sub>	3.13	3.47	V
High-level output voltage ( $BV_{DD} = min, I_{OH} = -2 mA$ )	V <sub>OH</sub>	BV <sub>DD</sub> – 0.2	_	V
Low-level output voltage (BV <sub>DD</sub> = min, I <sub>OL</sub> = 2 mA)	V <sub>OL</sub>	_	0.2	V

 Table 47. GP<sub>OUT</sub> DC Electrical Characteristics (3.3 V DC)

 Table 48. GP<sub>OUT</sub> DC Electrical Characteristics (2.5 V DC)

Parameter	Symbol	Min	Мах	Unit
Supply voltage 2.5 V	BV <sub>DD</sub>	2.37	2.63	V
High-level output voltage (BV <sub>DD</sub> = min, I <sub>OH</sub> = −1 mA)	V <sub>OH</sub>	2.0	BV <sub>DD</sub> + 0.3	V
Low-level output voltage (BV <sub>DD</sub> min, I <sub>OL</sub> = 1 mA)	V <sub>OL</sub>	GND – 0.3	0.4	V

Table 49 and Table 50 provide the DC electrical characteristics for the GP<sub>IN</sub> interface.

Table 49. GP<sub>IN</sub> DC Electrical Characteristics (3.3 V DC)

Parameter	Symbol	Min	Мах	Unit
Supply voltage 3.3 V	BV <sub>DD</sub>	3.13	3.47	V
High-level input voltage	V <sub>IH</sub>	2	BV <sub>DD</sub> + 0.3	V
Low-level input voltage	V <sub>IL</sub>	-0.3	0.8	V
Input current ( $BV_{IN}^{1} = 0 V \text{ or } BV_{IN} = BV_{DD}$ )	I <sub>IN</sub>	—	±5	μΑ

Note:

1. The symbol  $\mathsf{BV}_{\mathsf{IN}}$ , in this case, represents the  $\mathsf{BV}_{\mathsf{IN}}$  symbol referenced in Table 1.

#### PCI/PCI-X

Figure 36 shows the PCI/PCI-X input AC timing conditions.



Figure 36. PCI/PCI-X Input AC Timing Measurement Conditions

Figure 37 shows the PCI/PCI-X output AC timing conditions.





Table 53 provides the PCI-X AC timing specifications at 66 MHz.

	Table 53	. PCI-X AC	Timing	<b>Specifications</b>	at 66	MHz
--	----------	------------	--------	-----------------------	-------	-----

Parameter	Symbol	Min	Max	Unit	Notes
SYSCLK to signal valid delay	<sup>t</sup> PCKHOV	_	3.8	ns	1, 2, 3, 7, 8
Output hold from SYSCLK	t <sub>PCKHOX</sub>	0.7		ns	1, 10
SYSCLK to output high impedance	t <sub>PCKHOZ</sub>	-	7	ns	1, 4, 8, 11
Input setup time to SYSCLK	t <sub>PCIVKH</sub>	1.7	_	ns	3, 5
Input hold time from SYSCLK	t <sub>PCIXKH</sub>	0.5	_	ns	10
REQ64 to HRESET setup time	t <sub>PCRVRH</sub>	10	_	clocks	11
HRESET to REQ64 hold time	t <sub>PCRHRX</sub>	0	50	ns	11
HRESET high to first FRAME assertion	t <sub>PCRHFV</sub>	10	_	clocks	9, 11
PCI-X initialization pattern to HRESET setup time	<sup>t</sup> PCIVRH	10	_	clocks	11

- The SD\_REF\_CLK and SD\_REF\_CLK are internally AC-coupled differential inputs as shown in Figure 39. Each differential clock input (SD\_REF\_CLK or SD\_REF\_CLK) has a 50-Ω termination to SGND\_SRDSn (xcorevss) followed by on-chip AC-coupling.
- The external reference clock driver must be able to drive this termination.
- The SerDes reference clock input can be either differential or single-ended. See the differential mode and single-ended mode description below for further detailed requirements.
- The maximum average current requirement that also determines the common mode voltage range:
  - When the SerDes reference clock differential inputs are DC coupled externally with the clock driver chip, the maximum average current allowed for each input pin is 8 mA. In this case, the exact common mode input voltage is not critical as long as it is within the range allowed by the maximum average current of 8 mA (see the following bullet for more detail), since the input is AC-coupled on-chip.
  - This current limitation sets the maximum common mode input voltage to be less than 0.4 V (0.4 V/50 = 8 mA) while the minimum common mode input level is 0.1 V above SGND\_SRDS*n* (xcorevss). For example, a clock with a 50/50 duty cycle can be produced by a clock driver with output driven by its current source from 0 to 16 mA (0–0.8 V), such that each phase of the differential input has a single-ended swing from 0 V to 800 mV with the common mode voltage at 400 mV.
  - If the device driving the SD\_REF\_CLK and  $\overline{\text{SD}_{\text{REF}_{\text{CLK}}}}$  inputs cannot drive 50  $\Omega$  to SGND\_SRDS*n* (xcorevss) DC, or it exceeds the maximum input current limitations, then it must be AC-coupled off-chip.
- The input amplitude requirement:
  - This requirement is described in detail in the following sections.



Figure 39. Receiver of SerDes Reference Clocks

### 16.2.2 DC Level Requirement for SerDes Reference Clocks

The DC level requirement for the SerDes reference clock inputs is different depending on the signaling mode used to connect the clock driver chip and SerDes reference clock inputs as described below:

• Differential mode

# 16.2.4 AC Requirements for SerDes Reference Clocks

The clock driver selected must provide a high quality reference clock with low phase noise and cycle-to-cycle jitter. Phase noise less than 100 kHz can be tracked by the PLL and data recovery loops and is less of a problem. Phase noise above 15 MHz is filtered by the PLL. The most problematic phase noise occurs in the 1–15 MHz range. The source impedance of the clock driver must be 50  $\Omega$  to match the transmission line and reduce reflections which are a source of noise to the system.

The detailed AC requirements of the SerDes reference clocks are defined by each interface protocol based on application usage. See the following sections for detailed information:

- Section 17.2, "AC Requirements for PCI Express SerDes Clocks"
- Section 18.2, "AC Requirements for Serial RapidIO SD\_REF\_CLK and SD\_REF\_CLK"

### 16.2.4.1 Spread Spectrum Clock

SD\_REF\_CLK/SD\_REF\_CLK are designed to work with a spread spectrum clock (+0% to -0.5% spreading at 30–33 kHz rate is allowed), assuming both ends have same reference clock. For better results, a source without significant unintended modulation must be used.

## 16.3 SerDes Transmitter and Receiver Reference Circuits

Figure 47 shows the reference circuits for SerDes data lane's transmitter and receiver.



Figure 47. SerDes Transmitter and Receiver Reference Circuits

The DC and AC specification of SerDes data lanes are defined in each interface protocol section below (PCI Express, Serial Rapid IO, or SGMII) in this document based on the application usage:

- Section 17, "PCI Express"
- Section 18, "Serial RapidIO"

Note that external an AC coupling capacitor is required for the above three serial transmission protocols with the capacitor value defined in the specification of each protocol section.

#### **PCI Express**



Figure 48. Minimum Transmitter Timing and Voltage Output Compliance Specifications

### 17.4.3 Differential Receiver (RX) Input Specifications

Table 57 defines the specifications for the differential input at all receivers (RXs). The parameters are specified at the component pins.

Symbol	Parameter	Min	Nom	Max	Unit	Comments
UI	Unit interval	399.88	400	400.12	ps	Each UI is 400 ps $\pm$ 300 ppm. UI does not account for spread spectrum clock dictated variations. See Note 1.
V <sub>RX-DIFFp-p</sub>	Differential peak-to-peak input voltage	0.175	_	1.200	V	$V_{RX-DIFFp-p} = 2 \times  V_{RX-D+} - V_{RX-D-} $ . See Note 2.
T <sub>RX-EYE</sub>	Minimum receiver eye width	0.4	_	_	UI	The maximum interconnect media and transmitter jitter that can be tolerated by the receiver can be derived as $T_{RX-MAX-JITTER} = 1 - T_{RX-EYE} = 0.6$ UI. See Notes 2 and 3.
T <sub>RX-EYE-MEDIAN-to-</sub> MAX-JITTER	Maximum time between the jitter median and maximum deviation from the median	_	_	0.3	UI	Jitter is defined as the measurement variation of the crossing points ( $V_{RX-DIFFp-p} = 0$ V) in relation to a recovered TX UI. A recovered TX UI is calculated over 3500 consecutive unit intervals of sample data. Jitter is measured using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the TX UI. See Notes 2, 3, and 7.

Table 57. Differential Receiver (RX) Input Specifications

## 18.5 Explanatory Note on Transmitter and Receiver Specifications

AC electrical specifications are given for transmitter and receiver. Long- and short-run interfaces at three baud rates (a total of six cases) are described.

The parameters for the AC electrical specifications are guided by the XAUI electrical interface specified in Clause 47 of IEEE 802.3ae-2002.

XAUI has similar application goals to Serial RapidIO, as described in Section 8.1. The goal of this standard is that electrical designs for Serial RapidIO can reuse electrical designs for XAUI, suitably modified for applications at the baud intervals and reaches described herein.

# 18.6 Transmitter Specifications

LP-serial transmitter electrical and timing specifications are stated in the text and tables of this section.

The differential return loss, S11, of the transmitter in each case shall be better than:

- -10 dB for (baud frequency)/10 < Freq(f) < 625 MHz, and
- $-10 \text{ dB} + 10\log(f/625 \text{ MHz}) \text{ dB}$  for  $625 \text{ MHz} \le \text{Freq}(f) \le \text{baud}$  frequency

The reference impedance for the differential return loss measurements is  $100-\Omega$  resistive. Differential return loss includes contributions from on-chip circuitry, chip packaging, and any off-chip components related to the driver. The output impedance requirement applies to all valid output levels.

It is recommended that the 20%–80% rise/fall time of the transmitter, as measured at the transmitter output, in each case have a minimum value 60 ps.

It is recommended that the timing skew at the output of an LP-serial transmitter between the two signals that comprise a differential pair not exceed 25 ps at 1.25 GB, 20 ps at 2.50 GB, and 15 ps at 3.125 GB.

Characteristic	Symbol	Range		Unit	Notos	
Characteristic	Symbol	Min	Max	Unit	NOIES	
Output voltage	Vo	-0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair	
Differential output voltage	V <sub>DIFFPP</sub>	500	1000	mV p-p	_	
Deterministic jitter	J <sub>D</sub>	_	0.17	UI p-p	_	
Total jitter	J <sub>T</sub>	_	0.35	UI p-p	_	
Multiple output skew	S <sub>MO</sub>	—	1000	ps	Skew at the transmitter output between lanes of a multilane link	
Unit Interval	UI	800	800	ps	±100 ppm	

Table 59. Short Run Transmitter AC Timing Specifications—1.25 GBaud

#### Serial RapidIO

Table 60. Short Run Transmitter	AC Timing Specifications-	–2.5 GBaud
---------------------------------	---------------------------	------------

Characteristic	Symbol	Range		l lmit	Neter	
Characteristic	Symbol Min Max		Unit	Notes		
Output voltage	V <sub>O</sub>	-0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair	
Differential output voltage	V <sub>DIFFPP</sub>	500	1000	mV p-p	_	
Deterministic jitter	J <sub>D</sub>	—	0.17	UI p-p	_	
Total jitter	J <sub>T</sub>	—	0.35	UI p-p	_	
Multiple output skew	S <sub>MO</sub>	—	1000	ps	Skew at the transmitter output between lanes of a multilane link	
Unit interval	UI	400	400	ps	±100 ppm	

### Table 61. Short Run Transmitter AC Timing Specifications—3.125 GBaud

Characteristic	Symbol	Range		Unit	Notos	
Characteristic	Symbol	Min	Max	Onic	Notes	
Output voltage	V <sub>O</sub>	-0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair	
Differential output voltage	V <sub>DIFFPP</sub>	500	1000	mVp-p	_	
Deterministic jitter	J <sub>D</sub>	_	0.17	UI p-p	_	
Total jitter	J <sub>T</sub>	_	0.35	UI p-p	_	
Multiple output skew	S <sub>MO</sub>		1000	ps	Skew at the transmitter output between lanes of a multilane link	
Unit interval	UI	320	320	ps	±100 ppm	

### Table 62. Long Run Transmitter AC Timing Specifications—1.25 GBaud

Characteristic	Symbol	Range		Unit	Nataa	
	Symbol	Min	Max	Onic	10165	
Output voltage	V <sub>O</sub>	-0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair	
Differential output voltage	V <sub>DIFFPP</sub>	800	1600	mVp-p	_	
Deterministic jitter	J <sub>D</sub>	—	0.17	UI p-p	_	
Total jitter	J <sub>T</sub>	—	0.35	UI p-p	_	
Multiple output skew	S <sub>MO</sub>	—	1000	ps	Skew at the transmitter output between lanes of a multilane link	
Unit interval	UI	800	800	ps	±100 ppm	

Package Description

Signal	Package Pin Number	Pin Type	Power Supply	Notes
PCI1_REQ[4:1]	AH2, AG4, AG3, AH4	l	OV <sub>DD</sub>	—
				_
				_
				_
				_
PCI1_REQ0	AH3	I/O	OV <sub>DD</sub>	—
PCI1_CLK	AH26	I	OV <sub>DD</sub>	39
PCI1_DEVSEL	AH11	I/O	OV <sub>DD</sub>	2
PCI1_FRAME	AE11	I/O	OV <sub>DD</sub>	2
PCI1_IDSEL	AG9	I	OV <sub>DD</sub>	—
PCI1_REQ64/PCI2_FRAME	AF14	I/O	OV <sub>DD</sub>	2, 5, 10
PCI1_ACK64/PCI2_DEVSEL	V15	I/O	OV <sub>DD</sub>	2
PCI2_CLK	AE28	I	OV <sub>DD</sub>	39
PCI2_IRDY	AD26	I/O	OV <sub>DD</sub>	2
PCI2_PERR	AD25	I/O	OV <sub>DD</sub>	2
PCI2_GNT[4:1]	AE26, AG24, AF25, AE25	0	OV <sub>DD</sub>	5, 9, 35
PCI2_GNT0	AG25	I/O	OV <sub>DD</sub>	_
PCI2_SERR	AD24	I/O	OV <sub>DD</sub>	2, 4
PCI2_STOP	AF24	I/O	OV <sub>DD</sub>	2
PCI2_TRDY	AD27	I/O	OV <sub>DD</sub>	2
PCI2_REQ[4:1]	AD28, AE27, W17, AF26	I	OV <sub>DD</sub>	—
PCI2_REQ0	AH25	I/O	OV <sub>DD</sub>	—
	DDR SDRAM Memory Interface			
MDQ[0:63]	L18, J18, K14, L13, L19, M18, L15, L14, A17, B17, A13, B12, C18, B18, B13, A12, H18, F18, J14, F15, K19, J19, H16, K15, D17, G16, K13, D14, D18, F17, F14, E14, A7, A6, D5, A4, C8, D7, B5, B4, A2, B1, D1, E4, A3, B2, D2, E3, F3, G4, J5, K5, F6, G5, J6, K4, J1, K2, M5, M3, J3, J2, L1, M6	I/O	GV <sub>DD</sub>	
MECC[0:7]	H13, F13, F11, C11, J13, G13, D12, M12	I/O	GV <sub>DD</sub>	—
MDM[0:8]	M17, C16, K17, E16, B6, C4, H4, K1, E13	0	GV <sub>DD</sub>	
MDQS[0:8]	M15, A16, G17, G14, A5, D3, H1, L2, C13	I/O	GV <sub>DD</sub>	_
MDQS[0:8]	L17, B16, J16, H14, C6, C2, H3, L4, D13	I/O	GV <sub>DD</sub>	_
MA[0:15]	A8, F9, D9, B9, A9, L10, M10, H10, K10, G10, B8, E10, B10, G6, A10, L11	0	GV <sub>DD</sub>	_
MBA[0:2]	F7, J7, M11	0	GV <sub>DD</sub>	_

### Table 71. MPC8548E Pinout Listing (continued)

Table 71	. MPC8548E	<b>Pinout Listing</b>	(continued)
----------	------------	-----------------------	-------------

Signal	Package Pin Number	Pin Type	Power Supply	Notes
	Clock			
RTC	AF16	I	OV <sub>DD</sub>	—
SYSCLK	AH17	I	OV <sub>DD</sub>	—
	JTAG			
ТСК	AG28	I	OV <sub>DD</sub>	—
TDI	AH28	I	OV <sub>DD</sub>	12
TDO	AF28	0	OV <sub>DD</sub>	—
TMS	AH27	ļ	OV <sub>DD</sub>	12
TRST	AH23	I	OV <sub>DD</sub>	12
	DFT			
L1_TSTCLK	AC25	I	OV <sub>DD</sub>	25
L2_TSTCLK	AE22	I	OV <sub>DD</sub>	25
LSSD_MODE	AH20	I	OV <sub>DD</sub>	25
TEST_SEL	AH14	I	OV <sub>DD</sub>	25
	Thermal Management			
THERM0	AG1	—	—	14
THERM1	AH1	—	_	14
	Power Management			
ASLEEP	AH18	0	OV <sub>DD</sub>	9, 19, 29
	Power and Ground Signals			
GND	<ul> <li>A11, B7, B24, C1, C3, C5, C12, C15, C26, D8, D11, D16, D20, D22, E1, E5, E9, E12, E15, E17,</li> <li>F4, F26, G12, G15, G18, G21, G24, H2, H6, H8, H28, J4, J12, J15, J17, J27, K7, K9, K11, K27,</li> <li>L3, L5, L12, L16, N11, N13, N15, N17, N19, P4, P9, P12, P14, P16, P18, R11, R13, R15, R17, R19, T4, T12, T14, T16, T18, U8, U11, U13,</li> <li>U15, U17, U19, V4, V12, V18, W6, W19, Y4, Y9, Y11, Y19, AA6, AA14, AA17, AA22, AA23, AB4, AC2, AC11, AC19, AC26, AD5, AD9, AD22, AE3, AE14, AF6, AF10, AF13, AG8, AG27,</li> <li>K28, L24, L26, N24, N27, P25, R28, T24, T26,</li> <li>U24, V25, W28, Y24, Y26, AA24, AA27, AB25,</li> <li>AC28, L21, L23, N22, P20, R23, T21, U22, V20, W23, Y21, U27</li> </ul>		_	_
OV <sub>DD</sub>	V16, W11, W14, Y18, AA13, AA21, AB11, AB17, AB24, AC4, AC9, AC21, AD6, AD13, AD17, AD19, AE10, AE8, AE24, AF4, AF12, AF22, AF27, AG26	Power for PCI and other standards (3.3 V)	OV <sub>DD</sub>	—

Package Description

Signal	Package Pin Number	Pin Type	Power Supply	Notes
LV <sub>DD</sub>	N8, R7, T9, U6	Power for TSEC1 and TSEC2 (2.5 V, 3.3 V)	LV <sub>DD</sub>	_
TV <sub>DD</sub>	W9, Y6	Power for TSEC3 and TSEC4 (2,5 V, 3.3 V)	TV <sub>DD</sub>	_
GV <sub>DD</sub>	B3, B11, C7, C9, C14, C17, D4, D6, D10, D15, E2, E8, E11, E18, F5, F12, F16, G3, G7, G9, G11, H5, H12, H15, H17, J10, K3, K12, K16, K18, L6, M4, M8, M13	Power for DDR1 and DDR2 DRAM I/O voltage (1.8 V, 2.5)	GV <sub>DD</sub>	_
BV <sub>DD</sub>	C21, C24, C27, E20, E25, G19, G23, H26, J20	Power for local bus (1.8 V, 2.5 V, 3.3 V)	ΒV <sub>DD</sub>	-
V <sub>DD</sub>	M19, N12, N14, N16, N18, P11, P13, P15, P17, P19, R12, R14, R16, R18, T11, T13, T15, T17, T19, U12, U14, U16, U18, V17, V19	Power for core (1.1 V)	V <sub>DD</sub>	-
SV <sub>DD</sub>	L25, L27, M24, N28, P24, P26, R24, R27, T25, V24, V26, W24, W27, Y25, AA28, AC27	Core Power for SerDes transceivers (1.1 V)	SV <sub>DD</sub>	_
XV <sub>DD</sub>	L20, L22, N23, P21, R22, T20, U23, V21, W22, Y20	Pad Power for SerDes transceivers (1.1 V)	XV <sub>DD</sub>	_
AVDD_LBIU	J28	Power for local bus PLL (1.1 V)	_	26
AVDD_PCI1	AH21	Power for PCI1 PLL (1.1 V)	_	26
AVDD_PCI2	AH22	Power for PCI2 PLL (1.1 V)	_	26
AVDD_CORE	AH15	Power for e500 PLL (1.1 V)	_	26
AVDD_PLAT	AH19	Powerfor CCB PLL (1.1 V)	—	26
AVDD_SRDS	U25	Power for SRDSPLL (1.1 V)	—	26
SENSEVDD	M14	0	V <sub>DD</sub>	13

### Table 71. MPC8548E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
TSEC2_TX_ER	R10	0	LV <sub>DD</sub>	5, 9, 33
Three	e-Speed Ethernet Controller (Gigabit Ethe	ernet 3)		
TSEC3_TXD[3:0]	V8, W10, Y10, W7	0	TV <sub>DD</sub>	5, 9, 29
TSEC3_RXD[3:0]	Y1, W3, W5, W4	I	TV <sub>DD</sub>	_
TSEC3_GTX_CLK	W8	0	TV <sub>DD</sub>	_
TSEC3_RX_CLK	W2	I	TV <sub>DD</sub>	_
TSEC3_RX_DV	W1	I	TV <sub>DD</sub>	—
TSEC3_RX_ER	Y2	I	TV <sub>DD</sub>	_
TSEC3_TX_CLK	V10	I	TV <sub>DD</sub>	_
TSEC3_TX_EN	V9	0	TV <sub>DD</sub>	30
Three	-Speed Ethernet Controller (Gigabit Ethe	ernet 4)	<u> </u>	
TSEC4_TXD[3:0]/TSEC3_TXD[7:4]	AB8, Y7, AA7, Y8	0	TV <sub>DD</sub>	1, 5, 9, 29
TSEC4_RXD[3:0]/TSEC3_RXD[7:4]	AA1, Y3, AA2, AA4	I	TV <sub>DD</sub>	1
TSEC4_GTX_CLK	AA5	0	TV <sub>DD</sub>	
TSEC4_RX_CLK/TSEC3_COL	Y5	I	TV <sub>DD</sub>	1
TSEC4_RX_DV/TSEC3_CRS	AA3	I/O	TV <sub>DD</sub>	1, 31
TSEC4_TX_EN/TSEC3_TX_ER	AB6	0	TV <sub>DD</sub>	1, 30
· · ·	DUART			
UART_CTS[0:1]	AB3, AC5	I	OV <sub>DD</sub>	—
UART_RTS[0:1]	AC6, AD7	0	OV <sub>DD</sub>	—
UART_SIN[0:1]	AB5, AC7	I	OV <sub>DD</sub>	—
UART_SOUT[0:1]	AB7, AD8	0	OV <sub>DD</sub>	—
· · ·	I <sup>2</sup> C Interface			
IIC1_SCL	AG22	I/O	OV <sub>DD</sub>	4, 27
IIC1_SDA	AG21	I/O	OV <sub>DD</sub>	4, 27
IIC2_SCL	AG15	I/O	OV <sub>DD</sub>	4, 27
IIC2_SDA	AG14	I/O	OV <sub>DD</sub>	4, 27
· · · · · ·	SerDes	·		
SD_RX[0:3]	M28, N26, P28, R26	I	XV <sub>DD</sub>	—
SD_RX[0:3]	M27, N25, P27, R25	I	XV <sub>DD</sub>	—
SD_TX[0:3]	M22, N20, P22, R20	0	XV <sub>DD</sub>	_
SD_TX[0:3]	M23, N21, P23, R21	0	XV <sub>DD</sub>	—
Reserved	W26, Y28, AA26, AB28	—	<u> </u>	40
Reserved	W25, Y27, AA25, AB27	—	-	40

### Table 72. MPC8547E Pinout Listing (continued)

Package Description

Signal	Package Pin Number	Pin Type	Power Supply	Notes		
PCI1_TRDY	AG11	I/O	OV <sub>DD</sub>	2		
PCI1_REQ[4:1]	AH2, AG4, AG3, AH4		OV <sub>DD</sub>	—		
PCI1_REQ0	AH3	I/O	OV <sub>DD</sub>	—		
PCI1_CLK	AH26	I	OV <sub>DD</sub>	39		
PCI1_DEVSEL	AH11	I/O	OV <sub>DD</sub>	2		
PCI1_FRAME	AE11	I/O	OV <sub>DD</sub>	2		
PCI1_IDSEL	AG9	I	OV <sub>DD</sub>	—		
cfg_pci1_width	AF14	I/O	OV <sub>DD</sub>	112		
Reserved	V15		—	110		
Reserved	AE28	_		2		
Reserved	AD26		—	110		
Reserved	AD25		—	110		
Reserved	AE26		—	110		
cfg_pci1_clk	AG24	I	OV <sub>DD</sub>	5		
Reserved	AF25	_	_	101		
Reserved	AE25	_		110		
Reserved	AG25		—	110		
Reserved	AD24	_	—	110		
Reserved	AF24	_	—	110		
Reserved	AD27	_	_	110		
Reserved	AD28, AE27, W17, AF26		—	110		
Reserved	AH25		—	110		
DDR SDRAM Memory Interface						
MDQ[0:63]	L18, J18, K14, L13, L19, M18, L15, L14, A17, B17, A13, B12, C18, B18, B13, A12, H18, F18, J14, F15, K19, J19, H16, K15, D17, G16, K13, D14, D18, F17, F14, E14, A7, A6, D5, A4, C8, D7, B5, B4, A2, B1, D1, E4, A3, B2, D2, E3, F3, G4, J5, K5, F6, G5, J6, K4, J1, K2, M5, M3, J3, J2, L1, M6	I/O	GV <sub>DD</sub>	_		
MECC[0:7]	H13, F13, F11, C11, J13, G13, D12, M12	I/O	GV <sub>DD</sub>	—		
MDM[0:8]	M17, C16, K17, E16, B6, C4, H4, K1, E13	0	GV <sub>DD</sub>			
MDQS[0:8]	M15, A16, G17, G14, A5, D3, H1, L2, C13	I/O	GV <sub>DD</sub>	—		
MDQS[0:8]	L17, B16, J16, H14, C6, C2, H3, L4, D13	I/O	GV <sub>DD</sub>			
MA[0:15]	A8, F9, D9, B9, A9, L10, M10, H10, K10, G10, B8, E10, B10, G6, A10, L11	0	GV <sub>DD</sub>	—		
MBA[0:2]	F7, J7, M11	0	GV <sub>DD</sub>	_		

### Table 74. MPC8543E Pinout Listing (continued)

# 21 Thermal

This section describes the thermal specifications of the device.

# 21.1 Thermal for Version 2.0 Silicon HiCTE FC-CBGA with Full Lid

This section describes the thermal specifications for the HiCTE FC-CBGA package for revision 2.0 silicon.

This table shows the package thermal characteristics.

Characteristic	JEDEC Board	Symbol	Value	Unit	Notes
Die junction-to-ambient (natural convection)	Single-layer board (1s)	$R_{ extsf{ heta}JA}$	17	°C/W	1, 2
Die junction-to-ambient (natural convection)	Four-layer board (2s2p)	$R_{ extsf{ heta}JA}$	12	°C/W	1, 2
Die junction-to-ambient (200 ft/min)	Single-layer board (1s)	$R_{ extsf{ heta}JA}$	11	°C/W	1, 2
Die junction-to-ambient (200 ft/min)	Four-layer board (2s2p)	$R_{ extsf{ heta}JA}$	8	°C/W	1, 2
Die junction-to-board	N/A	$R_{\thetaJB}$	3	°C/W	3
Die junction-to-case	N/A	$R_{ extsf{ heta}JC}$	0.8	°C/W	4

Table 84. Package Thermal Characteristics for HiCTE FC-CBGA

Notes:

- 1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, airflow, power dissipation of other components on the board, and board thermal resistance.
- 2. Per JEDEC JESD51-6 with the board (JESD51-7) horizontal.
- 3. Thermal resistance between the die and the printed-circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
- 4. Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1). The cold plate temperature is used for the case temperature, measured value includes the thermal resistance of the interface layer.

# 21.2 Thermal for Version 2.1.1, 2.1.2, and 2.1.3 Silicon FC-PBGA with Full Lid and Version 3.1.x Silicon with Stamped Lid

This section describes the thermal specifications for the FC-PBGA package for revision 2.1.1, 2.1.2, and 3.0 silicon.

This table shows the package thermal characteristics.

Table 85. Package	Thermal	Characteristics	for FC-PBGA
-------------------	---------	-----------------	-------------

Characteristic	JEDEC Board	Symbol	Value	Unit	Notes
Die junction-to-ambient (natural convection)	Single-layer board (1s)	$R_{ extsf{ heta}JA}$	18	°C/W	1, 2
Die junction-to-ambient (natural convection)	Four-layer board (2s2p)	$R_{ extsf{ heta}JA}$	13	°C/W	1, 2
Die junction-to-ambient (200 ft/min)	Single-layer board (1s)	$R_{ extsf{ heta}JA}$	13	°C/W	1, 2
Die junction-to-ambient (200 ft/min)	Four-layer board (2s2p)	$R_{ extsf{ heta}JA}$	9	°C/W	1, 2